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### **Understanding Embedded - FPGAs (Field Programmable Gate Array)**

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

### **Applications of Embedded - FPGAs**

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications,

#### **Details**

Product Status	Active
Number of LABs/CLBs	12675
Number of Logic Elements/Cells	162240
Total RAM Bits	11980800
Number of I/O	400
Number of Gates	-
Voltage - Supply	0.87V ~ 0.93V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 100°C (Tj)
Package / Case	676-BBGA, FCBGA
Supplier Device Package	676-FCBGA (27x27)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/xilinx/xc7k160t-l2ffg676e">https://www.e-xfl.com/product-detail/xilinx/xc7k160t-l2ffg676e</a>

Table 5: Maximum Allowed AC Voltage Overshoot and Undershoot for 1.8V HP I/O Banks<sup>(1)(2)</sup> (Cont'd)

AC Voltage Overshoot	% of UI @-40°C to 100°C	AC Voltage Undershoot	% of UI @-40°C to 100°C
V <sub>CCO</sub> + 0.80	9.71	-0.80	50.0
V <sub>CCO</sub> + 0.85	4.51	-0.85	28.4
V <sub>CCO</sub> + 0.90	2.12	-0.90	12.7
V <sub>CCO</sub> + 0.95	1.01	-0.95	5.79

**Notes:**

1. A total of 200 mA per bank should not be exceeded.
2. For UI smaller than 20 µs.

Table 6: Typical Quiescent Supply Current

Symbol	Description	Device	Speed Grade				Units	
			1.0V		0.9V			
			-3	-2/-2L	-1	-2L		
I <sub>CCINTQ</sub>	Quiescent V <sub>CCINT</sub> supply current	XC7K70T	241	241	241	187	mA	
		XC7K160T	474	474	474	368	mA	
		XC7K325T	810	810	810	629	mA	
		XC7K355T	993	993	993	771	mA	
		XC7K410T	1080	1080	1080	838	mA	
		XC7K420T	1313	1313	1313	1019	mA	
		XC7K480T	1313	1313	1313	1019	mA	
I <sub>CCOQ</sub>	Quiescent V <sub>CCO</sub> supply current	XC7K70T	1	1	1	1	mA	
		XC7K160T	1	1	1	1	mA	
		XC7K325T	1	1	1	1	mA	
		XC7K355T	1	1	1	1	mA	
		XC7K410T	1	1	1	1	mA	
		XC7K420T	1	1	1	1	mA	
		XC7K480T	1	1	1	1	mA	
I <sub>CCAUXQ</sub>	Quiescent V <sub>CCAUX</sub> supply current	XC7K70T	21	21	21	21	mA	
		XC7K160T	40	40	40	40	mA	
		XC7K325T	68	68	68	68	mA	
		XC7K355T	75	75	75	75	mA	
		XC7K410T	85	85	85	85	mA	
		XC7K420T	99	99	99	99	mA	
		XC7K480T	99	99	99	99	mA	
I <sub>CCAUX_IOQ</sub>	Quiescent V <sub>CCAUX_IO</sub> supply current	XC7K70T	N/A	N/A	N/A	N/A	mA	
		XC7K160T	2	2	2	2	mA	
		XC7K325T	2	2	2	2	mA	
		XC7K355T	N/A	N/A	N/A	N/A	mA	
		XC7K410T	2	2	2	2	mA	
		XC7K420T	N/A	N/A	N/A	N/A	mA	
		XC7K480T	N/A	N/A	N/A	N/A	mA	

Table 6: Typical Quiescent Supply Current (Cont'd)

Symbol	Description	Device	Speed Grade				Units
			1.0V			0.9V	
			-3	-2/-2L	-1	-2L	
I <sub>CCBRAMQ</sub>	Quiescent V <sub>CCBRAM</sub> supply current	XC7K70T	6	6	6	6	mA
		XC7K160T	14	14	14	14	mA
		XC7K325T	19	19	19	19	mA
		XC7K355T	31	31	31	31	mA
		XC7K410T	34	34	34	34	mA
		XC7K420T	41	41	41	41	mA
		XC7K480T	41	41	41	41	mA

**Notes:**

1. Typical values are specified at nominal voltage, 85°C junction temperatures ( $T_j$ ) with single-ended SelectIO resources.
2. Typical values are for blank configured devices with no output current loads, no active input pull-up resistors, all I/O pins are 3-state and floating.
3. Use the XPower™ Estimator (XPE) spreadsheet tool (download at <http://www.xilinx.com/power>) to calculate static power consumption for conditions other than those specified.

## Power-On/Off Power Supply Sequencing

The recommended power-on sequence is  $V_{CCINT}$ ,  $V_{CCBRAM}$ ,  $V_{CCAUX}$ ,  $V_{CCAUX\_IO}$ , and  $V_{CCO}$  to achieve minimum current draw and ensure that the I/Os are 3-stated at power-on. The recommended power-off sequence is the reverse of the power-on sequence. If  $V_{CCINT}$  and  $V_{CCBRAM}$  have the same recommended voltage levels then both can be powered by the same supply and ramped simultaneously. If  $V_{CCAUX}$ ,  $V_{CCAUX\_IO}$ , and  $V_{CCO}$  have the same recommended voltage levels then they can be powered by the same supply and ramped simultaneously.

For  $V_{CCO}$  voltages of 3.3V in HR I/O banks and configuration bank 0:

- The voltage difference between  $V_{CCO}$  and  $V_{CCAUX}$  must not exceed 2.625V for longer than  $T_{VCCO2VCCAUX}$  for each power-on/off cycle to maintain device reliability levels.
- The  $T_{VCCO2VCCAUX}$  time can be allocated in any percentage between the power-on and power-off ramps.

The recommended power-on sequence to achieve minimum current draw for the GTX transceivers is  $V_{CCINT}$ ,  $V_{MGTAVCC}$ ,  $V_{MGTAVTT}$  OR  $V_{MGTAVCC}$ ,  $V_{CCINT}$ ,  $V_{MGTAVTT}$ . There is no recommended sequencing for  $V_{MGTAVCCAUX}$ . Both  $V_{MGTAVCC}$  and  $V_{CCINT}$  can be ramped simultaneously. The recommended power-off sequence is the reverse of the power-on sequence to achieve minimum current draw.

If these recommended sequences are not met, current drawn from  $V_{MGTAVTT}$  can be higher than specifications during power-up and power-down.

- When  $V_{MGTAVTT}$  is powered before  $V_{MGTAVCC}$  and  $V_{MGTAVTT} - V_{MGTAVCC} > 150$  mV and  $V_{MGTAVCC} < 0.7V$ , the  $V_{MGTAVTT}$  current draw can increase by 460 mA per transceiver during  $V_{MGTAVCC}$  ramp up. The duration of the current draw can be up to  $0.3 \times T_{MGTAVCC}$  (ramp time from GND to 90% of  $V_{MGTAVCC}$ ). The reverse is true for power-down.
- When  $V_{MGTAVTT}$  is powered before  $V_{CCINT}$  and  $V_{MGTAVTT} - V_{CCINT} > 150$  mV and  $V_{CCINT} < 0.7V$ , the  $V_{MGTAVTT}$  current draw can increase by 50 mA per transceiver during  $V_{CCINT}$  ramp up. The duration of the current draw can be up to  $0.3 \times T_{VCCINT}$  (ramp time from GND to 90% of  $V_{CCINT}$ ). The reverse is true for power-down.

## DC Input and Output Levels

Values for  $V_{IL}$  and  $V_{IH}$  are recommended input voltages. Values for  $I_{OL}$  and  $I_{OH}$  are guaranteed over the recommended operating conditions at the  $V_{OL}$  and  $V_{OH}$  test points. Only selected standards are tested. These are chosen to ensure that all standards meet their specifications. The selected standards are tested at a minimum  $V_{CCO}$  with the respective  $V_{OL}$  and  $V_{OH}$  voltage levels shown. Other standards are sample tested.

Table 9: SelectIO DC Input and Output Levels (1)(2)

I/O Standard	$V_{IL}$		$V_{IH}$		$V_{OL}$	$V_{OH}$	$I_{OL}$	$I_{OH}$
	$V$ , Min	$V$ , Max	$V$ , Min	$V$ , Max	$V$ , Max	$V$ , Min	mA	mA
HSTL_I	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	8	-8
HSTL_I_12	-0.300	$V_{REF} - 0.080$	$V_{REF} + 0.080$	$V_{CCO} + 0.300$	25% $V_{CCO}$	75% $V_{CCO}$	6.3	-6.3
HSTL_I_18	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	8	-8
HSTL_II	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	16	-16
HSTL_II_18	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	16	-16
HSUL_12	-0.300	$V_{REF} - 0.130$	$V_{REF} + 0.130$	$V_{CCO} + 0.300$	20% $V_{CCO}$	80% $V_{CCO}$	0.1	-0.1
LVCMOS12	-0.300	35% $V_{CCO}$	65% $V_{CCO}$	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	Note 3	Note 3
LVCMOS15, LVDCI_15	-0.300	35% $V_{CCO}$	65% $V_{CCO}$	$V_{CCO} + 0.300$	25% $V_{CCO}$	75% $V_{CCO}$	Note 4	Note 4
LVCMOS18, LVDCI_18	-0.300	35% $V_{CCO}$	65% $V_{CCO}$	$V_{CCO} + 0.300$	0.450	$V_{CCO} - 0.450$	Note 5	Note 5
LVCMOS25	-0.300	0.700	1.700	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	Note 6	Note 6
LVCMOS33	-0.300	0.800	2.000	3.450	0.400	$V_{CCO} - 0.400$	Note 6	Note 6
LVTTL	-0.300	0.800	2.000	3.450	0.400	2.400	Note 7	Note 7
MOBILE_DDR	-0.300	20% $V_{CCO}$	80% $V_{CCO}$	$V_{CCO} + 0.300$	10% $V_{CCO}$	90% $V_{CCO}$	0.1	-0.1
PCI33_3	-0.500	30% $V_{CCO}$	50% $V_{CCO}$	$V_{CCO} + 0.500$	10% $V_{CCO}$	90% $V_{CCO}$	1.5	-0.5
SSTL12	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.150$	$V_{CCO}/2 + 0.150$	14.25	-14.25
SSTL135	-0.300	$V_{REF} - 0.090$	$V_{REF} + 0.090$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.150$	$V_{CCO}/2 + 0.150$	13.0	-13.0
SSTL135_R	-0.300	$V_{REF} - 0.090$	$V_{REF} + 0.090$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.150$	$V_{CCO}/2 + 0.150$	8.9	-8.9
SSTL15	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.175$	$V_{CCO}/2 + 0.175$	13.0	-13.0
SSTL15_R	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.175$	$V_{CCO}/2 + 0.175$	8.9	-8.9
SSTL18_I	-0.300	$V_{REF} - 0.125$	$V_{REF} + 0.125$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.470$	$V_{CCO}/2 + 0.470$	8	-8
SSTL18_II	-0.300	$V_{REF} - 0.125$	$V_{REF} + 0.125$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.600$	$V_{CCO}/2 + 0.600$	13.4	-13.4

### Notes:

- Tested according to relevant specifications.
- 3.3V and 2.5V standards are only supported in 3.3V I/O banks.
- Supported drive strengths of 2, 4, 6, or 8 mA in HP I/O banks and 4, 8, or 12 mA in HR I/O banks.
- Supported drive strengths of 2, 4, 6, 8, 12, or 16 mA in HP I/O banks and 4, 8, 12, or 16 mA in HR I/O banks.
- Supported drive strengths of 2, 4, 6, 8, 12, or 16 mA in HP I/O banks and 4, 8, 12, 16, or 24 mA in HR I/O banks.
- Supported drive strengths of 4, 8, 12, or 16 mA
- Supported drive strengths of 4, 8, 12, 16, or 24 mA
- For detailed interface specific DC voltage levels, see [UG471: 7 Series FPGAs SelectIO Resources User Guide](#).

Table 10: Differential SelectIO DC Input and Output Levels

I/O Standard	V <sub>ICM</sub> <sup>(1)</sup>			V <sub>ID</sub> <sup>(2)</sup>			V <sub>OCM</sub> <sup>(3)</sup>			V <sub>OD</sub> <sup>(4)</sup>		
	V, Min	V, Typ	V, Max	V, Min	V, Typ	V, Max	V, Min	V, Typ	V, Max	V, Min	V, Typ	V, Max
BLVDS_25	0.300	1.200	1.425	0.100	—	—	—	1.250	—	Note 5		
MINI_LVDS_25	0.300	1.200	V <sub>CCAUX</sub>	0.200	0.400	0.600	1.000	1.200	1.400	0.300	0.450	0.600
PPDS_25	0.200	0.900	V <sub>CCAUX</sub>	0.100	0.250	0.400	0.500	0.950	1.400	0.100	0.250	0.400
RSDS_25	0.300	0.900	1.500	0.100	0.350	0.600	1.000	1.200	1.400	0.100	0.350	0.600
TMDS_33	2.700	2.965	3.230	0.150	0.675	1.200	V <sub>CCO</sub> –0.405	V <sub>CCO</sub> –0.300	V <sub>CCO</sub> –0.190	0.400	0.600	0.800

**Notes:**

1. V<sub>ICM</sub> is the input common mode voltage.
2. V<sub>ID</sub> is the input differential voltage (Q –  $\bar{Q}$ ).
3. V<sub>OCM</sub> is the output common mode voltage.
4. V<sub>OD</sub> is the output differential voltage (Q –  $\bar{Q}$ ).
5. V<sub>OD</sub> for BLVDS will vary significantly depending on topology and loading.
6. LVDS\_25 is specified in Table 12.
7. LVDS is specified in Table 13.

Table 11: Complementary Differential SelectIO DC Input and Output Levels

I/O Standard	V <sub>ICM</sub> <sup>(1)</sup>			V <sub>ID</sub> <sup>(2)</sup>			V <sub>OL</sub> <sup>(3)</sup>		V <sub>OH</sub> <sup>(4)</sup>		I <sub>OL</sub>		I <sub>OH</sub>
	V, Min	V, Typ	V, Max	V, Min	V, Max	V, Max	V, Min	mA, Max	mA, Min	V, Min	mA, Max	mA, Min	
DIFF_HSTL_I	0.300	0.750	1.125	0.100	—	0.400	V <sub>CCO</sub> –0.400	8.00	—8.00				
DIFF_HSTL_I_18	0.300	0.900	1.425	0.100	—	0.400	V <sub>CCO</sub> –0.400	8.00	—8.00				
DIFF_HSTL_II	0.300	0.750	1.125	0.100	—	0.400	V <sub>CCO</sub> –0.400	16.00	—16.00				
DIFF_HSTL_II_18	0.300	0.900	1.425	0.100	—	0.400	V <sub>CCO</sub> –0.400	16.00	—16.00				
DIFF_HSUL_12	0.300	0.600	0.850	0.100	—	20% V <sub>CCO</sub>	80% V <sub>CCO</sub>	0.100	—0.100				
DIFF_MOBILE_DDR	0.300	0.900	1.425	0.100	—	10% V <sub>CCO</sub>	90% V <sub>CCO</sub>	0.100	—0.100				
DIFF_SSTL12	0.300	0.600	0.850	0.100	—	(V <sub>CCO</sub> /2) – 0.150	(V <sub>CCO</sub> /2) + 0.150	14.25	—14.25				
DIFF_SSTL135	0.300	0.675	1.000	0.100	—	(V <sub>CCO</sub> /2) – 0.150	(V <sub>CCO</sub> /2) + 0.150	13.0	—13.0				
DIFF_SSTL135_R	0.300	0.675	1.000	0.100	—	(V <sub>CCO</sub> /2) – 0.150	(V <sub>CCO</sub> /2) + 0.150	8.9	—8.9				
DIFF_SSTL15	0.300	0.750	1.125	0.100	—	(V <sub>CCO</sub> /2) – 0.175	(V <sub>CCO</sub> /2) + 0.175	13.0	—13.0				
DIFF_SSTL15_R	0.300	0.750	1.125	0.100	—	(V <sub>CCO</sub> /2) – 0.175	(V <sub>CCO</sub> /2) + 0.175	8.9	—8.9				
DIFF_SSTL18_I	0.300	0.900	1.425	0.100	—	(V <sub>CCO</sub> /2) – 0.470	(V <sub>CCO</sub> /2) + 0.470	8.00	—8.00				
DIFF_SSTL18_II	0.300	0.900	1.425	0.100	—	(V <sub>CCO</sub> /2) – 0.600	(V <sub>CCO</sub> /2) + 0.600	13.4	—13.4				

**Notes:**

1. V<sub>ICM</sub> is the input common mode voltage.
2. V<sub>ID</sub> is the input differential voltage (Q –  $\bar{Q}$ ).
3. V<sub>OL</sub> is the single-ended low-output voltage.
4. V<sub>OH</sub> is the single-ended high-output voltage.

## Production Silicon and ISE Software Status

In some cases, a particular family member (and speed grade) is released to production before a speed specification is released with the correct label (Advance, Preliminary, Production). Any labeling discrepancies are corrected in subsequent speed specification releases.

**Table 15** lists the production released Kintex-7 device, speed grade, and the minimum corresponding supported speed specification version and ISE software revisions. The ISE software and speed specifications listed are the minimum releases required for production. All subsequent releases of software and speed specifications are valid.

**Table 15: Kintex-7 Device Production Software and Speed Specification Release**

Device	Speed Grade Designations			
	1.0V		0.9V	
	-3	-2/-2L	-1	-2L
XC7K70T		ISE 14.2 v1.06		ISE 14.3 v1.06
XC7K160T		ISE 14.2 v1.06		ISE 14.3 v1.06
XC7K325T		ISE 14.2 v1.06		ISE 14.3 v1.06
XC7K355T		ISE 14.2 v1.06		ISE 14.3 v1.06
XC7K410T		ISE 14.2 v1.06		ISE 14.3 v1.06
XC7K420T		ISE 14.2 v1.06		ISE 14.3 v1.06
XC7K480T		ISE 14.2 v1.06		ISE 14.3 v1.06

## Performance Characteristics

This section provides the performance characteristics of some common functions and designs implemented in Kintex-7 devices. The numbers reported here are worst-case values; they have all been fully characterized. These values are subject to the same guidelines as the [AC Switching Characteristics, page 11](#). In each table, the I/O bank type is either High Performance (HP) or High Range (HR).

**Table 16: Networking Applications Interface Performances**

Description	I/O Bank Type	Speed Grade				Units	
		1.0V		0.9V			
		-3	-2/-2L	-1	-2L		
SDR LVDS transmitter (using OSERDES; DATA_WIDTH = 4 to 8)	HR	710	710	625	625	Mb/s	
	HP	710	710	625	625	Mb/s	
DDR LVDS transmitter (using OSERDES; DATA_WIDTH = 4 to 14)	HR	1250	1250	950	950	Mb/s	
	HP	1600	1400	1250	1250	Mb/s	
SDR LVDS receiver (SFI-4.1) <sup>(1)</sup>	HR	710	710	625	625	Mb/s	
	HP	710	710	625	625	Mb/s	
DDR LVDS receiver (SPI-4.2) <sup>(1)</sup>	HR	1250	1250	950	950	Mb/s	
	HP	1600	1400	1250	1250	Mb/s	

### Notes:

- LVDS receivers are typically bounded with certain applications where specific dynamic phase-alignment (DPA) algorithms dominate deterministic performance.

Table 18: Maximum Physical Interface (PHY) Rate for Memory Interfaces (FBG Packages)<sup>(1)(2)</sup>

Memory Standard	I/O Bank Type	V <sub>CCAUX_IO</sub> <sup>(3)</sup>	Speed Grade				Units
			1.0V		0.9V		
			-3	-2/-2L	-1	-2L	
<b>4:1 Memory Controllers</b>							
DDR3	HP	N/A	1333	1066	800	800	Mb/s
	HR	N/A	1066	800	800	800	Mb/s
DDR3L	HP	N/A	1066	800	667	667	Mb/s
	HR	N/A	800	800	667	667	Mb/s
DDR2	HP	N/A	800	800	800	800	Mb/s
	HR	N/A	800	667	667	667	Mb/s
RLDRAM III <sup>(4)</sup>	HP	N/A	550	500	450	450	MHz
	HR	N/A			N/A		
<b>2:1 Memory Controllers</b>							
DDR3	HP	N/A	1066	1066	800	800	Mb/s
	HR	N/A	1066	800	800	800	Mb/s
DDR3L	HP	N/A	1066	800	667	667	Mb/s
	HR	N/A	800	800	667	667	Mb/s
DDR2	HP	N/A	800	800	800	800	Mb/s
	HR	N/A	800	667	667	667	Mb/s
QDR II+ <sup>(5)</sup>	HP	N/A	550	500	450	450	MHz
	HR	N/A	450	400	350	350	MHz
RLDRAM II	HP	N/A	533	500	450	450	MHz
	HR	N/A					
LPDDR2 <sup>(4)</sup>	HP	N/A	667	667	667	667	Mb/s
	HR	N/A	667	667	533	533	Mb/s

**Notes:**

1. V<sub>REF</sub> tracking is required. For more information, see [UG586, 7 Series FPGAs Memory Interface Solutions User Guide](#).
2. When using the internal V<sub>REF</sub> the maximum data rate is 800 Mb/s (400 MHz).
3. FBG packages do not have separate V<sub>CCAUX\_IO</sub> supply pins to adjust the pre-driver voltage of the HP I/O banks.
4. RLDRAM III (BL = 4, BL = 8) and LPDDR2 specifications have not been validated with memory IP.
5. The maximum QDRII+ performance specifications are for burst-length 4 (BL = 4) implementations. Burst length 2 (BL = 2) implementations are limited to 333 MHz for all speed grades and I/O bank types.

Table 19: 3.3V IOB High Range (HR) Switching Characteristics (Cont'd)

I/O Standard	T <sub>IOPI</sub>				T <sub>IOOP</sub>				T <sub>IOTP</sub>				Units	
	Speed Grade				Speed Grade				Speed Grade					
	1.0V		0.9V		1.0V		0.9V		1.0V		0.9V			
	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L		
LVCMOS15_S16	0.66	0.69	0.81	0.90	1.76	1.95	2.13	1.91	2.52	2.81	3.12	2.42	ns	
LVCMOS15_F4	0.66	0.69	0.81	0.90	3.39	3.60	3.80	1.98	4.15	4.46	4.79	2.50	ns	
LVCMOS15_F8	0.66	0.69	0.81	0.90	1.79	1.99	2.18	1.92	2.55	2.85	3.17	2.44	ns	
LVCMOS15_F12	0.66	0.69	0.81	0.90	1.40	1.54	1.65	1.67	2.16	2.40	2.64	2.19	ns	
LVCMOS15_F16	0.66	0.69	0.81	0.90	1.37	1.51	1.61	1.66	2.13	2.37	2.60	2.17	ns	
LVCMOS12_S4	0.88	0.91	1.00	1.01	3.85	4.22	4.69	2.89	4.61	5.08	5.68	3.41	ns	
LVCMOS12_S8	0.88	0.91	1.00	1.01	2.52	2.96	3.52	2.41	3.28	3.82	4.51	2.92	ns	
LVCMOS12_S12 <sup>(1)</sup>	0.88	0.91	1.00	1.01	2.06	2.31	2.59	2.11	2.82	3.17	3.58	2.63	ns	
LVCMOS12_F4	0.88	0.91	1.00	1.01	3.44	3.73	4.06	2.30	4.20	4.59	5.05	2.81	ns	
LVCMOS12_F8	0.88	0.91	1.00	1.01	1.72	2.04	2.40	1.86	2.48	2.90	3.39	2.38	ns	
LVCMOS12_F12 <sup>(1)</sup>	0.88	0.91	1.00	1.01	1.54	1.71	1.87	1.69	2.30	2.57	2.86	2.20	ns	
SSTL135_S	0.61	0.64	0.73	0.79	1.27	1.40	1.50	1.64	2.03	2.26	2.49	2.16	ns	
SSTL15_S	0.61	0.64	0.73	0.73	1.24	1.37	1.47	1.59	2.00	2.23	2.46	2.11	ns	
SSTL18_I_S	0.64	0.67	0.76	0.79	1.59	1.74	1.85	1.95	2.35	2.60	2.84	2.47	ns	
SSTL18_II_S	0.64	0.67	0.76	0.78	1.27	1.40	1.50	1.63	2.03	2.26	2.49	2.14	ns	
DIFF_SSTL135_S	0.59	0.61	0.73	0.79	1.27	1.40	1.50	1.64	2.03	2.26	2.49	2.16	ns	
DIFF_SSTL15_S	0.63	0.67	0.77	0.79	1.24	1.37	1.47	1.59	2.00	2.23	2.46	2.11	ns	
DIFF_SSTL18_I_S	0.65	0.69	0.78	0.79	1.50	1.63	1.72	1.95	2.26	2.49	2.71	2.47	ns	
DIFF_SSTL18_II_S	0.65	0.69	0.78	0.79	1.13	1.22	1.25	1.66	1.89	2.08	2.24	2.17	ns	
SSTL135_F	0.61	0.64	0.73	0.79	1.04	1.17	1.26	1.42	1.80	2.03	2.25	1.94	ns	
SSTL15_F	0.61	0.64	0.73	0.73	1.04	1.17	1.26	1.39	1.80	2.03	2.25	1.91	ns	
SSTL18_I_F	0.64	0.67	0.76	0.79	1.12	1.22	1.26	1.44	1.88	2.08	2.25	1.95	ns	
SSTL18_II_F	0.64	0.67	0.76	0.78	1.05	1.18	1.28	1.42	1.81	2.04	2.27	1.94	ns	
DIFF_SSTL135_F	0.59	0.61	0.73	0.79	1.04	1.17	1.26	1.42	1.80	2.03	2.25	1.94	ns	
DIFF_SSTL15_F	0.63	0.67	0.77	0.79	1.04	1.17	1.26	1.39	1.80	2.03	2.25	1.91	ns	
DIFF_SSTL18_I_F	0.65	0.69	0.78	0.79	1.10	1.19	1.23	1.52	1.86	2.05	2.22	2.03	ns	
DIFF_SSTL18_II_F	0.65	0.69	0.78	0.79	1.02	1.10	1.14	1.50	1.78	1.96	2.13	2.02	ns	

**Notes:**

1. This I/O standard is only available in the 3.3V high-range (HR) banks.

Table 20: 1.8V IOB High Performance (HP) Switching Characteristics

I/O Standard	T <sub>IOPI</sub>				T <sub>IOOP</sub>				T <sub>IOTP</sub>				Units	
	Speed Grade				Speed Grade				Speed Grade					
	1.0V		0.9V		1.0V		0.9V		1.0V		0.9V			
	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L		
LVDS	0.75	0.79	0.92	0.89	1.05	1.17	1.24	1.43	1.68	1.92	2.06	2.04	ns	
HSUL_12	0.69	0.72	0.82	0.95	1.65	1.84	2.05	1.80	2.29	2.59	2.87	2.41	ns	
DIFF_HSUL_12	0.69	0.72	0.82	0.92	1.65	1.84	2.05	1.47	2.29	2.59	2.87	2.08	ns	
HSTL_I_S	0.68	0.72	0.82	0.84	1.15	1.28	1.38	1.46	1.79	2.03	2.20	2.07	ns	
HSTL_II_S	0.68	0.72	0.82	0.84	1.05	1.17	1.26	1.44	1.69	1.93	2.08	2.05	ns	
HSTL_I_18_S	0.70	0.72	0.82	0.86	1.12	1.24	1.34	1.41	1.75	2.00	2.16	2.02	ns	
HSTL_II_18_S	0.70	0.72	0.82	0.86	1.06	1.18	1.26	1.44	1.70	1.94	2.08	2.05	ns	
HSTL_I_12_S	0.68	0.72	0.82	0.94	1.14	1.27	1.37	1.43	1.78	2.02	2.20	2.04	ns	
HSTL_I_DCI_S	0.68	0.72	0.82	0.78	1.11	1.23	1.33	1.36	1.74	1.99	2.15	1.98	ns	
HSTL_II_DCI_S	0.68	0.72	0.82	0.78	1.05	1.17	1.26	1.33	1.69	1.93	2.08	1.94	ns	
HSTL_II_T_DCI_S	0.70	0.72	0.82	0.76	1.15	1.28	1.38	1.40	1.78	2.03	2.20	2.01	ns	
HSTL_I_DCI_18_S	0.70	0.72	0.82	0.76	1.11	1.23	1.33	1.36	1.74	1.99	2.15	1.98	ns	
HSTL_II_DCI_18_S	0.70	0.72	0.82	0.76	1.05	1.16	1.24	1.32	1.69	1.92	2.06	1.93	ns	
HSTL_II_T_DCI_18_S	0.70	0.72	0.82	0.76	1.11	1.23	1.33	1.36	1.74	1.99	2.15	1.98	ns	
DIFF_HSTL_I_S	0.75	0.79	0.92	0.89	1.15	1.28	1.38	1.47	1.79	2.03	2.20	2.08	ns	
DIFF_HSTL_II_S	0.75	0.79	0.92	0.89	1.05	1.17	1.26	1.47	1.69	1.93	2.08	2.08	ns	
DIFF_HSTL_I_DCI_S	0.75	0.79	0.92	0.76	1.15	1.28	1.38	1.47	1.78	2.03	2.20	2.08	ns	
DIFF_HSTL_II_DCI_S	0.75	0.79	0.92	0.76	1.05	1.17	1.26	1.40	1.69	1.93	2.08	2.01	ns	
DIFF_HSTL_I_18_S	0.75	0.79	0.92	0.89	1.12	1.24	1.34	1.46	1.75	2.00	2.16	2.07	ns	
DIFF_HSTL_II_18_S	0.75	0.79	0.92	0.89	1.06	1.18	1.26	1.47	1.70	1.94	2.08	2.08	ns	
DIFF_HSTL_I_DCI_18_S	0.75	0.79	0.92	0.75	1.11	1.23	1.33	1.46	1.74	1.99	2.15	2.07	ns	
DIFF_HSTL_II_DCI_18_S	0.75	0.79	0.92	0.75	1.05	1.16	1.24	1.41	1.69	1.92	2.06	2.02	ns	
DIFF_HSTL_II_T_DCI_18_S	0.75	0.79	0.92	0.76	1.11	1.23	1.33	1.46	1.74	1.99	2.15	2.07	ns	
HSTL_I_F	0.68	0.72	0.82	0.84	1.02	1.14	1.22	1.26	1.66	1.90	2.04	1.87	ns	
HSTL_II_F	0.68	0.72	0.82	0.84	0.97	1.08	1.15	1.29	1.61	1.84	1.97	1.90	ns	
HSTL_I_18_F	0.70	0.72	0.82	0.86	1.04	1.16	1.24	1.32	1.68	1.91	2.06	1.93	ns	
HSTL_II_18_F	0.70	0.72	0.82	0.86	0.98	1.09	1.16	1.35	1.62	1.85	1.98	1.96	ns	
HSTL_I_12_F	0.68	0.72	0.82	0.94	1.02	1.13	1.21	1.26	1.65	1.88	2.03	1.87	ns	
HSTL_I_DCI_F	0.68	0.72	0.82	0.78	1.04	1.16	1.24	1.30	1.67	1.91	2.06	1.91	ns	
HSTL_II_DCI_F	0.68	0.72	0.82	0.78	0.97	1.08	1.15	1.22	1.61	1.84	1.97	1.83	ns	
HSTL_II_T_DCI_F	0.70	0.72	0.82	0.76	1.02	1.14	1.22	1.26	1.66	1.90	2.04	1.87	ns	
HSTL_I_DCI_18_F	0.70	0.72	0.82	0.76	1.04	1.16	1.24	1.30	1.67	1.91	2.06	1.91	ns	
HSTL_II_DCI_18_F	0.70	0.72	0.82	0.76	0.98	1.09	1.16	1.27	1.61	1.85	1.98	1.88	ns	
HSTL_II_T_DCI_18_F	0.70	0.72	0.82	0.76	1.04	1.16	1.24	1.30	1.67	1.91	2.06	1.91	ns	
DIFF_HSTL_I_F	0.75	0.79	0.92	0.89	1.02	1.14	1.22	1.35	1.66	1.90	2.04	1.96	ns	
DIFF_HSTL_II_F	0.75	0.79	0.92	0.89	0.97	1.08	1.15	1.35	1.61	1.84	1.97	1.96	ns	
DIFF_HSTL_I_DCI_F	0.75	0.79	0.92	0.76	1.02	1.14	1.22	1.35	1.66	1.90	2.04	1.96	ns	

**Table 21** specifies the values of  $T_{IOTPHZ}$  and  $T_{IOIBUFDISABLE}$ .  $T_{IOTPHZ}$  is described as the delay from the T pin to the IOB pad through the output buffer of an IOB pad, when 3-state is enabled (i.e., a high impedance state).  $T_{IOIBUFDISABLE}$  is described as the IOB delay from IBUFDISABLE to O output. In HP I/O banks, the internal DCI termination turn-off time is always faster than  $T_{IOTPHZ}$  when the DCITERMDISABLE pin is used. In HR I/O banks, the internal IN\_TERM termination turn-off time is always faster than  $T_{IOTPHZ}$  when the INTERMDISABLE pin is used.

Table 21: IOB 3-state Output Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
$T_{IOTPHZ}$	T input to pad high-impedance	0.76	0.86	0.99	0.62	ns
$T_{IOIBUFDISABLE\_HR}$	IBUF turn-on time from IBUFDISABLE to O output for HR I/O banks	1.72	1.89	2.14	2.17	ns
$T_{IOIBUFDISABLE\_HP}$	IBUF turn-on time from IBUFDISABLE to O output for HP I/O banks	1.31	1.46	1.76	1.86	ns

## Input Serializer/Deserializer Switching Characteristics

Table 24: ISERDES Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Setup/Hold for Control Lines</b>						
T <sub>ISCKC_BITSIP</sub> /T <sub>ISCKC_BITSIP</sub>	BITSIP pin Setup/Hold with respect to CLKDIV	0.01/0.12	0.02/0.13	0.02/0.15	0.02/0.21	ns
T <sub>ISCKC_CE</sub> /T <sub>ISCKC_CE</sub> <sup>(2)</sup>	CE pin Setup/Hold with respect to CLK (for CE1)	0.39/-0.02	0.44/-0.02	0.63/-0.02	0.51/-0.22	ns
T <sub>ISCKC_CE2</sub> /T <sub>ISCKC_CE2</sub> <sup>(2)</sup>	CE pin Setup/Hold with respect to CLKDIV (for CE2)	-0.12/0.29	-0.12/0.31	-0.12/0.35	-0.17/0.40	ns
<b>Setup/Hold for Data Lines</b>						
T <sub>ISDCK_D</sub> /T <sub>ISCKD_D</sub>	D pin Setup/Hold with respect to CLK	-0.02/0.11	-0.02/0.12	-0.02/0.15	-0.04/0.19	ns
T <sub>ISDCK_DDLY</sub> /T <sub>ISCKD_DDLY</sub>	DDLY pin Setup/Hold with respect to CLK (using IDELAY) <sup>(1)</sup>	-0.02/0.11	-0.02/0.12	-0.02/0.15	-0.03/0.19	ns
T <sub>ISDCK_D_DDR</sub> /T <sub>ISCKD_D_DDR</sub>	D pin Setup/Hold with respect to CLK at DDR mode	-0.02/0.11	-0.02/0.12	-0.02/0.15	-0.04/0.19	ns
T <sub>ISDCK_DDLY_DDR</sub> /T <sub>ISCKD_DDLY_DDR</sub>	D pin Setup/Hold with respect to CLK at DDR mode (using IDELAY) <sup>(1)</sup>	0.11/0.11	0.12/0.12	0.15/0.15	0.19/0.19	ns
<b>Sequential Delays</b>						
T <sub>ISCKO_Q</sub>	CLKDIV to out at Q pin	0.46	0.47	0.58	0.67	ns
<b>Propagation Delays</b>						
T <sub>ISDO_DO</sub>	D input to DO output pin	0.09	0.10	0.12	0.14	ns

**Notes:**

1. Recorded at 0 tap value.
2. T<sub>ISCKC\_CE2</sub> and T<sub>ISCKC\_CE2</sub> are reported as T<sub>ISCKC\_CE</sub>/T<sub>ISCKC\_CE</sub> in TRACE report.

## CLB Switching Characteristics

Table 28: CLB Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Combinatorial Delays</b>						
T <sub>ILO</sub>	An – Dn LUT address to A	0.05	0.05	0.06	0.07	ns, Max
T <sub>ILO_2</sub>	An – Dn LUT address to AMUX/CMUX	0.15	0.16	0.19	0.22	ns, Max
T <sub>ILO_3</sub>	An – Dn LUT address to BMUX_A	0.24	0.25	0.30	0.37	ns, Max
T <sub>I TO</sub>	An – Dn inputs to A – D Q outputs	0.58	0.61	0.74	0.91	ns, Max
T <sub>AXA</sub>	AX inputs to AMUX output	0.38	0.40	0.49	0.62	ns, Max
T <sub>AXB</sub>	AX inputs to BMUX output	0.40	0.42	0.52	0.66	ns, Max
T <sub>AXC</sub>	AX inputs to CMUX output	0.39	0.41	0.50	0.62	ns, Max
T <sub>AXD</sub>	AX inputs to DMUX output	0.43	0.44	0.52	0.67	ns, Max
T <sub>BXB</sub>	BX inputs to BMUX output	0.31	0.33	0.40	0.51	ns, Max
T <sub>BXD</sub>	BX inputs to DMUX output	0.38	0.39	0.47	0.62	ns, Max
T <sub>CXC</sub>	CX inputs to CMUX output	0.27	0.28	0.34	0.43	ns, Max
T <sub>CXD</sub>	CX inputs to DMUX output	0.33	0.34	0.41	0.54	ns, Max
T <sub>DXD</sub>	DX inputs to DMUX output	0.32	0.33	0.40	0.52	ns, Max
<b>Sequential Delays</b>						
T <sub>CKO</sub>	Clock to AQ – DQ outputs	0.26	0.27	0.32	0.40	ns, Max
T <sub>SHCKO</sub>	Clock to AMUX – DMUX outputs	0.32	0.32	0.39	0.46	ns, Max
<b>Setup and Hold Times of CLB Flip-Flops Before/After Clock CLK</b>						
T <sub>AS/T<sub>AH</sub></sub>	A <sub>N</sub> – D <sub>N</sub> input to CLK on A – D Flip Flops	0.01/0.12	0.02/0.13	0.03/0.18	0.02/0.18	ns, Min
T <sub>DICK/T<sub>CKDI</sub></sub>	A <sub>X</sub> – D <sub>X</sub> input to CLK on A – D Flip Flops	0.04/0.14	0.04/0.14	0.05/0.20	0.05/0.21	ns, Min
	A <sub>X</sub> – D <sub>X</sub> input through MUXs and/or carry logic to CLK on A – D Flip Flops	0.36/0.10	0.37/0.11	0.46/0.16	0.56/0.15	ns, Min
T <sub>CECK_CLB/</sub> T <sub>CKCE_CLB</sub>	CE input to CLK on A – D Flip Flops	0.19/0.05	0.20/0.05	0.25/0.05	0.24/0.04	ns, Min
T <sub>SRCK/T<sub>CKSR</sub></sub>	SR input to CLK on A – D Flip Flops	0.30/0.05	0.31/0.07	0.37/0.09	0.48/0.05	ns, Min
<b>Set/Reset</b>						
T <sub>SRMIN</sub>	SR input minimum pulse width	0.52	0.78	1.04	0.95	ns, Min
T <sub>RQ</sub>	Delay from SR input to AQ – DQ flip-flops	0.38	0.38	0.46	0.59	ns, Max
T <sub>CEO</sub>	Delay from CE input to AQ – DQ flip-flops	0.34	0.35	0.43	0.54	ns, Max
F <sub>TOG</sub>	Toggle frequency (for export control)	1818	1818	1818	1286	MHz

## Block RAM and FIFO Switching Characteristics

Table 31: Block RAM and FIFO Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Block RAM and FIFO Clock-to-Out Delays</b>						
T <sub>RCKO_DO</sub> and T <sub>RCKO_DO_REG</sub> <sup>(1)</sup>	Clock CLK to DOUT output (without output register) <sup>(2)(3)</sup>	1.57	1.80	2.08	2.44	ns, Max
	Clock CLK to DOUT output (with output register) <sup>(4)(5)</sup>	0.54	0.63	0.75	0.86	ns, Max
T <sub>RCKO_DO_ECC</sub> and T <sub>RCKO_DO_ECC_REG</sub>	Clock CLK to DOUT output with ECC (without output register) <sup>(2)(3)</sup>	2.35	2.58	3.26	4.49	ns, Max
	Clock CLK to DOUT output with ECC (with output register) <sup>(4)(5)</sup>	0.62	0.69	0.80	0.94	ns, Max
T <sub>RCKO_DO_CASCOUP</sub> and T <sub>RCKO_DO_CASCOUP_REG</sub>	Clock CLK to DOUT output with Cascade (without output register) <sup>(2)</sup>	2.21	2.45	2.80	3.19	ns, Max
	Clock CLK to DOUT output with Cascade (with output register) <sup>(4)</sup>	0.98	1.08	1.24	1.32	ns, Max
T <sub>RCKO_FLAGS</sub>	Clock CLK to FIFO flags outputs <sup>(6)</sup>	0.65	0.74	0.89	0.97	ns, Max
T <sub>RCKO_POINTERS</sub>	Clock CLK to FIFO pointers outputs <sup>(7)</sup>	0.79	0.87	0.98	1.10	ns, Max
T <sub>RCKO_PARITY_ECC</sub>	Clock CLK to ECCPARITY in ECC encode only mode	0.66	0.72	0.80	0.93	ns, Max
T <sub>RCKO_SDBIT_ECC</sub> and T <sub>RCKO_SDBIT_ECC_REG</sub>	Clock CLK to BITERR (without output register)	2.17	2.38	3.01	4.15	ns, Max
	Clock CLK to BITERR (with output register)	0.57	0.65	0.76	0.89	ns, Max
T <sub>RCKO_RDADDR_ECC</sub> and T <sub>RCKO_RDADDR_ECC_REG</sub>	Clock CLK to RDADDR output with ECC (without output register)	0.64	0.74	0.90	0.98	ns, Max
	Clock CLK to RDADDR output with ECC (with output register)	0.71	0.79	0.92	1.10	ns, Max
<b>Setup and Hold Times Before/After Clock CLK</b>						
T <sub>RCKC_ADDRA</sub> /T <sub>RCKC_ADDRA</sub>	ADDR inputs <sup>(8)</sup>	0.38/0.27	0.42/0.28	0.48/0.31	0.65/0.38	ns, Min
T <sub>RDCK_DI_WF_NC</sub> / T <sub>RCKD_DI_WF_NC</sub>	Data input setup/hold time when block RAM is configured in WRITE_FIRST or NO_CHANGE mode <sup>(9)</sup>	0.49/0.51	0.55/0.53	0.63/0.57	0.78/0.64	ns, Min
T <sub>RDCK_DI_RF</sub> /T <sub>RCKD_DI_RF</sub>	Data input setup/hold time when block RAM is configured in READ_FIRST mode <sup>(9)</sup>	0.17/0.25	0.19/0.29	0.21/0.35	0.25/0.32	ns, Min
T <sub>RDCK_DI_ECC</sub> / T <sub>RCKD_DI_ECC</sub>	DIN inputs with block RAM ECC in standard mode <sup>(9)</sup>	0.42/0.37	0.47/0.39	0.53/0.43	0.66/0.46	ns, Min
T <sub>RDCK_DI_ECCW</sub> / T <sub>RCKD_DI_ECCW</sub>	DIN inputs with block RAM ECC encode only <sup>(9)</sup>	0.79/0.37	0.87/0.39	0.99/0.43	1.17/0.41	ns, Min
T <sub>RDCK_DI_ECC_FIFO</sub> / T <sub>RCKD_DI_ECC_FIFO</sub>	DIN inputs with FIFO ECC in standard mode <sup>(9)</sup>	0.89/0.47	0.98/0.50	1.12/0.54	1.32/0.65	ns, Min
T <sub>RCKC_INJECTBITERR</sub> / T <sub>RCKC_INJECTBITERR</sub>	Inject single/double bit error in ECC mode	0.49/0.30	0.55/0.31	0.63/0.34	0.78/0.41	ns, Min
T <sub>RCKC_EN</sub> /T <sub>RCKC_EN</sub>	Block RAM Enable (EN) input	0.30/0.17	0.33/0.18	0.38/0.20	0.48/0.22	ns, Min
T <sub>RCKC_REGCE</sub> /T <sub>RCKC_REGCE</sub>	CE input of output register	0.21/0.13	0.25/0.13	0.31/0.14	0.34/0.16	ns, Min
T <sub>RCKC_RSTREG</sub> /T <sub>RCKC_RSTREG</sub>	Synchronous RSTREG input	0.25/0.06	0.27/0.06	0.29/0.06	0.35/0.06	ns, Min

Table 31: Block RAM and FIFO Switching Characteristics (Cont'd)

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
T <sub>RCKC_RSTRAM</sub> /T <sub>RCKC_RSTRAM</sub>	Synchronous RSTRAM input	0.27/0.35	0.29/0.37	0.31/0.39	0.34/0.40	ns, Min
T <sub>RCKC_WEA</sub> /T <sub>RCKC_WEA</sub>	Write Enable (WE) input (Block RAM only)	0.38/0.15	0.41/0.16	0.46/0.17	0.54/0.19	ns, Min
T <sub>RCKC_WREN</sub> /T <sub>RCKC_WREN</sub>	WREN FIFO inputs	0.39/0.25	0.39/0.30	0.40/0.37	0.65/0.37	ns, Min
T <sub>RCKC_RDEN</sub> /T <sub>RCKC_RDEN</sub>	RDEN FIFO inputs	0.36/0.26	0.36/0.30	0.37/0.37	0.60/0.38	ns, Min
<b>Reset Delays</b>						
T <sub>RCO_FLAGS</sub>	Reset RST to FIFO flags/pointers <sup>(10)</sup>	0.76	0.83	0.93	1.06	ns, Max
T <sub>RREC_RST</sub> /T <sub>RREM_RST</sub>	FIFO reset recovery and removal timing <sup>(11)</sup>	1.59/-0.68	1.76/-0.68	2.01/-0.68	2.07/-0.60	ns, Max
<b>Maximum Frequency</b>						
F <sub>MAX_BRAM_WF_NC</sub>	Block RAM (Write first and No change modes) When not in SDP RF mode	601.32	543.77	458.09	372.44	MHz
F <sub>MAX_BRAM_RF_PERFORMANCE</sub>	Block RAM (Read first, Performance mode) When in SDP RF mode but no address overlap between port A and port B	601.32	543.77	458.09	372.44	MHz
F <sub>MAX_BRAM_RF_DELAYED_WRITE</sub>	Block RAM (Read first, Delayed_write mode) When in SDP RF mode and there is possibility of overlap between port A and port B addresses	528.26	477.33	400.80	317.36	MHz
F <sub>MAX_CAS_WF_NC</sub>	Block RAM Cascade (Write first, No change mode) When cascade but not in RF mode	551.27	493.83	408.00	322.48	MHz
F <sub>MAX_CAS_RF_PERFORMANCE</sub>	Block RAM Cascade (Read first, Performance mode) When in cascade with RF mode and no possibility of address overlap/one port is disabled	551.27	493.83	408.00	322.48	MHz
F <sub>MAX_CAS_RF_DELAYED_WRITE</sub>	When in cascade RF mode and there is a possibility of address overlap between port A and port B	478.27	427.35	350.88	267.38	MHz
F <sub>MAX_FIFO</sub>	FIFO in all modes without ECC	601.32	543.77	458.09	372.44	MHz
F <sub>MAX_ECC</sub>	Block RAM and FIFO in ECC configuration	484.26	430.85	351.12	254.13	MHz

**Notes:**

1. TRACE will report all of these parameters as T<sub>RCKO\_DO</sub>.
2. T<sub>RCKO\_DOR</sub> includes T<sub>RCKO\_DOW</sub>, T<sub>RCKO\_DOPR</sub>, and T<sub>RCKO\_DOPW</sub> as well as the B port equivalent timing parameters.
3. These parameters also apply to synchronous FIFO with DO\_REG = 0.
4. T<sub>RCKO\_DO</sub> includes T<sub>RCKO\_DOP</sub> as well as the B port equivalent timing parameters.
5. These parameters also apply to multirate (asynchronous) and synchronous FIFO with DO\_REG = 1.
6. T<sub>RCKO\_FLAGS</sub> includes the following parameters: T<sub>RCKO\_AEMPTY</sub>, T<sub>RCKO\_AFULL</sub>, T<sub>RCKO\_EMPTY</sub>, T<sub>RCKO\_FULL</sub>, T<sub>RCKO\_RDERR</sub>, T<sub>RCKO\_WRERR</sub>.
7. T<sub>RCKO\_POINTERS</sub> includes both T<sub>RCKO\_RDCOUNT</sub> and T<sub>RCKO\_WRCOUNT</sub>.
8. The ADDR setup and hold must be met when EN is asserted (even when WE is deasserted). Otherwise, block RAM data corruption is possible.
9. These parameters include both A and B inputs as well as the parity inputs of A and B.
10. T<sub>RCO\_FLAGS</sub> includes the following flags: AEMPTY, AFULL, EMPTY, FULL, RDERR, WRERR, RDCOUNT, and WRCOUNT.
11. RDEN and WREN must be held Low prior to and during reset. The FIFO reset must be asserted for at least five positive clock edges of the slowest clock (WRCLK or RDCLK).

Table 36: Horizontal Clock Buffer Switching Characteristics (BUFH)

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
T <sub>BHCKO_O</sub>	BUFH delay from I to O	0.10	0.11	0.13	0.12	ns
T <sub>BHCKC_CE</sub> /T <sub>BHCKC_CE</sub>	CE pin Setup and Hold	0.20/0.16	0.23/0.20	0.38/0.21	0.28/0.09	ns
<b>Maximum Frequency</b>						
F <sub>MAX_BUHF</sub>	Horizontal clock buffer (BUFH)	741.00	710.00	625.00	560.00	MHz

Table 37: Duty Cycle Distortion and Clock-Tree Skew

Symbol	Description	Device	Speed Grade				Units
			1.0V		0.9V		
			-3	-2/-2L	-1	-2L	
T <sub>DCD_CLK</sub>	Global Clock Tree Duty Cycle Distortion <sup>(1)</sup>	All	0.20	0.20	0.20	0.25	ns
T <sub>CKSKEW</sub>	Global Clock Tree Skew <sup>(2)</sup>	XC7K70T	0.29	0.40	0.40	0.47	ns
		XC7K160T	0.42	0.53	0.57	0.59	ns
		XC7K325T	0.59	0.74	0.79	0.91	ns
		XC7K355T	0.45	0.57	0.59	0.69	ns
		XC7K410T	0.60	0.74	0.79	0.91	ns
		XC7K420T	0.60	0.74	0.79	0.91	ns
		XC7K480T	0.60	0.74	0.79	0.91	ns
T <sub>DCD_BUFIO</sub>	I/O clock tree duty cycle distortion	All	0.12	0.12	0.12	0.12	ns
T <sub>BUFIOSKEW</sub>	I/O clock tree skew across one clock region	All	0.02	0.02	0.02	0.03	ns
T <sub>DCD_BUFR</sub>	Regional clock tree duty cycle distortion	All	0.15	0.15	0.15	0.15	ns

**Notes:**

1. These parameters represent the worst-case duty cycle distortion observable at the I/O flip flops. For all I/O standards, IBIS can be used to calculate any additional duty cycle distortion that might be caused by asymmetrical rise/fall times.
2. The T<sub>CKSKEW</sub> value represents the worst-case clock-tree skew observable between sequential I/O elements. Significantly less clock-tree skew exists for I/O registers that are close to each other and fed by the same or adjacent clock-tree branches. Use the Xilinx Timing Analyzer tools to evaluate clock skew specific to your application.

**Table 42: Clock-Capable Clock Input to Output Delay With MMCM**

Symbol	Description	Device	Speed Grade				Units
			1.0V		0.9V		
			-3	-2/-2L	-1	-2L	
SSTL15 Clock-Capable Clock Input to Output Delay using Output Flip-Flop, Fast Slew Rate, <i>with MMCM</i> .							
TICKOFMMCMCC	Clock-capable clock input and OUTFF <i>with MMCM</i>	XC7K70T	0.95	0.95	0.95	1.74	ns
		XC7K160T	0.96	0.96	0.96	1.78	ns
		XC7K325T	1.00	1.00	1.00	1.82	ns
		XC7K355T	1.00	1.00	1.00	1.78	ns
		XC7K410T	1.00	1.00	1.00	1.82	ns
		XC7K420T	1.07	1.07	1.07	1.82	ns
		XC7K480T	1.07	1.07	1.07	1.82	ns

**Notes:**

1. Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net.
2. MMCM output jitter is already included in the timing calculation.

**Table 43: Clock-Capable Clock Input to Output Delay With PLL**

Symbol	Description	Device	Speed Grade				Units
			1.0V		0.9V		
			-3	-2/-2L	-1	-2L	
SSTL15 Clock-Capable Clock Input to Output Delay using Output Flip-Flop, Fast Slew Rate, <i>with PLL</i> .							
TICKOFPLLCC	Clock-capable clock input and OUTFF <i>with PLL</i>	XC7K70T	0.84	0.84	0.84	1.45	ns
		XC7K160T	0.89	0.89	0.89	1.54	ns
		XC7K325T	0.89	0.89	0.89	1.54	ns
		XC7K355T	0.89	0.89	0.89	1.50	ns
		XC7K410T	0.89	0.89	0.89	1.54	ns
		XC7K420T	0.96	0.96	0.96	1.54	ns
		XC7K480T	0.96	0.96	0.96	1.54	ns

**Notes:**

1. Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net.
2. PLL output jitter is already included in the timing calculation.

**Table 44: Pin-to-Pin, Clock-to-Out using BUFI0**

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
SSTL15 Clock-Capable Clock Input to Output Delay using Output Flip-Flop, Fast Slew Rate, <i>with BUFI0</i> .						
TICKOFC0	Clock-to-Out of I/O clock for HR I/O banks	4.93	5.52	6.20	6.97	ns
	Clock-to-Out of I/O clock for HP I/O banks	4.85	5.44	6.11	6.90	ns

Table 47: Clock-Capable Clock Input Setup and Hold With PLL

Symbol	Description	Device	Speed Grade				Units
			1.0V		0.9V		
			-3	-2/-2L	-1	-2L	
Input Setup and Hold Time Relative to Clock-Capable Clock Input Signal for SSTL15 Standard. <sup>(1)</sup>							
$T_{PSPLLCC}/T_{PHPLLCC}$	No Delay clock-capable clock input and IFF <sup>(2)</sup> with PLL	XC7K70T	2.75/-0.32	3.04/-0.32	3.33/-0.32	2.42/-0.54	ns
		XC7K160T	2.85/-0.31	3.16/-0.31	3.46/-0.31	2.59/-0.56	ns
		XC7K325T	2.91/-0.27	3.24/-0.27	3.54/-0.27	2.80/-0.56	ns
		XC7K355T	2.79/-0.27	3.12/-0.27	3.40/-0.27	2.67/-0.52	ns
		XC7K410T	2.91/-0.27	3.24/-0.27	3.53/-0.27	2.78/-0.56	ns
		XC7K420T	2.83/-0.20	3.12/-0.20	3.41/-0.20	2.61/-0.50	ns
		XC7K480T	2.83/-0.20	3.12/-0.20	3.41/-0.20	2.61/-0.50	ns

**Notes:**

1. Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage.
2. IFF = Input Flip-Flop or Latch
3. Use IBIS to determine any duty-cycle distortion incurred using various standards.

Table 48: Data Input Setup and Hold Times Relative to a Forwarded Clock Input Pin Using BUFIN

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
Input Setup and Hold Time Relative to a Forwarded Clock Input Pin Using BUFIN for SSTL15 Standard.						
$T_{PSCS}/T_{PHCS}$	Setup/Hold of I/O clock for HR I/O banks	-0.36/1.36	-0.36/1.50	-0.36/1.70	-0.44/1.87	ns
	Setup/Hold of I/O clock for HP I/O banks	-0.34/1.39	-0.34/1.53	-0.34/1.73	-0.44/1.87	ns

Table 49: Sample Window

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
$T_{SAMP}$	Sampling Error at Receiver Pins <sup>(1)</sup>	0.51	0.56	0.61	0.56	ns
$T_{SAMP\_BUFIN}$	Sampling Error at Receiver Pins using BUFIN <sup>(2)</sup>	0.30	0.35	0.40	0.35	ns

**Notes:**

1. This parameter indicates the total sampling error of the Kintex-7 FPGAs DDR input registers, measured across voltage, temperature, and process. The characterization methodology uses the MMCM to capture the DDR input registers' edges of operation. These measurements include:
  - CLK0 MMCM jitter
  - MMCM accuracy (phase offset)
  - MMCM phase shift resolution
These measurements do not include package or clock tree skew.
2. This parameter indicates the total sampling error of the Kintex-7 FPGAs DDR input registers, measured across voltage, temperature, and process. The characterization methodology uses the BUFIN clock network and IDELAY to capture the DDR input registers' edges of operation. These measurements do not include package or clock tree skew.

Table 58: GTX Transceiver Transmitter Switching Characteristics (Cont'd)

Symbol	Description	Condition	Min	Typ	Max	Units
TJ <sub>10.3125</sub>	Total Jitter <sup>(2)(4)</sup>	10.3125 Gb/s	—	—	0.28	UI
DJ <sub>10.3125</sub>	Deterministic Jitter <sup>(2)(4)</sup>		—	—	0.17	UI
TJ <sub>9.953</sub>	Total Jitter <sup>(2)(4)</sup>	9.953 Gb/s	—	—	0.28	UI
DJ <sub>9.953</sub>	Deterministic Jitter <sup>(2)(4)</sup>		—	—	0.17	UI
TJ <sub>9.8</sub>	Total Jitter <sup>(2)(4)</sup>	9.8 Gb/s	—	—	0.28	UI
DJ <sub>9.8</sub>	Deterministic Jitter <sup>(2)(4)</sup>		—	—	0.17	UI
TJ <sub>8.0</sub>	Total Jitter <sup>(2)(4)</sup>	8.0 Gb/s	—	—	0.30	UI
DJ <sub>8.0</sub>	Deterministic Jitter <sup>(2)(4)</sup>		—	—	0.15	UI
TJ <sub>6.6_QPLL</sub>	Total Jitter <sup>(2)(4)</sup>	6.6 Gb/s	—	—	0.28	UI
DJ <sub>6.6_QPLL</sub>	Deterministic Jitter <sup>(2)(4)</sup>		—	—	0.17	UI
TJ <sub>6.6_CPLL</sub>	Total Jitter <sup>(3)(4)</sup>	6.6 Gb/s	—	—	0.30	UI
DJ <sub>6.6_CPLL</sub>	Deterministic Jitter <sup>(3)(4)</sup>		—	—	0.15	UI
TJ <sub>5.0</sub>	Total Jitter <sup>(3)(4)</sup>	5.0 Gb/s	—	—	0.30	UI
DJ <sub>5.0</sub>	Deterministic Jitter <sup>(3)(4)</sup>		—	—	0.15	UI
TJ <sub>4.25</sub>	Total Jitter <sup>(3)(4)</sup>	4.25 Gb/s	—	—	0.30	UI
DJ <sub>4.25</sub>	Deterministic Jitter <sup>(3)(4)</sup>		—	—	0.15	UI
TJ <sub>3.75</sub>	Total Jitter <sup>(3)(4)</sup>	3.75 Gb/s	—	—	0.30	UI
DJ <sub>3.75</sub>	Deterministic Jitter <sup>(3)(4)</sup>		—	—	0.15	UI
TJ <sub>3.2</sub>	Total Jitter <sup>(3)(4)</sup>	3.20 Gb/s <sup>(5)</sup>	—	—	0.2	UI
DJ <sub>3.2</sub>	Deterministic Jitter <sup>(3)(4)</sup>		—	—	0.1	UI
TJ <sub>3.2L</sub>	Total Jitter <sup>(3)(4)</sup>	3.20 Gb/s <sup>(6)</sup>	—	—	0.32	UI
DJ <sub>3.2L</sub>	Deterministic Jitter <sup>(3)(4)</sup>		—	—	0.16	UI
TJ <sub>2.5</sub>	Total Jitter <sup>(3)(4)</sup>	2.5 Gb/s <sup>(7)</sup>	—	—	0.20	UI
DJ <sub>2.5</sub>	Deterministic Jitter <sup>(3)(4)</sup>		—	—	0.08	UI
TJ <sub>1.25</sub>	Total Jitter <sup>(3)(4)</sup>	1.25 Gb/s <sup>(8)</sup>	—	—	0.15	UI
DJ <sub>1.25</sub>	Deterministic Jitter <sup>(3)(4)</sup>		—	—	0.06	UI
TJ <sub>500</sub>	Total Jitter <sup>(3)(4)</sup>	500 Mb/s	—	—	0.1	UI
DJ <sub>500</sub>	Deterministic Jitter <sup>(3)(4)</sup>		—	—	0.03	UI

**Notes:**

1. Using same REFCLK input with TX phase alignment enabled for up to 12 consecutive transmitters (three fully populated GTX Quads).
2. Using QPLL\_FBDIV = 40, 20-bit internal data width. These values are NOT intended for protocol specific compliance determinations.
3. Using CPLL\_FBDIV = 2, 20-bit internal data width. These values are NOT intended for protocol specific compliance determinations.
4. All jitter values are based on a bit-error ratio of  $1e^{-12}$ .
5. CPLL frequency at 3.2 GHz and TXOUT\_DIV = 2.
6. CPLL frequency at 1.6 GHz and TXOUT\_DIV = 1.
7. CPLL frequency at 2.5 GHz and TXOUT\_DIV = 2.
8. CPLL frequency at 2.5 GHz and TXOUT\_DIV = 4.

Table 68: Configuration Switching Characteristics (Cont'd)

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Master/Slave Serial Mode Programming Switching</b>						
T <sub>DCCCK</sub> /T <sub>CCKD</sub>	DIN Setup/Hold	4.00/0.00	4.00/0.00	4.00/0.00	5.00/0.00	ns, Min
T <sub>CCO</sub>	DOUT clock to out	8.00	8.00	8.00	9.00	ns, Max
<b>SelectMAP Mode Programming Switching</b>						
T <sub>SMDCCCK</sub> /T <sub>SMCCKD</sub>	D[31:00] Setup/Hold	4.00/0.00	4.00/0.00	4.00/0.00	4.50/0.00	ns, Min
T <sub>SMCSCK</sub> /T <sub>SMCCKS</sub>	CSI_B Setup/Hold	4.00/0.00	4.00/0.00	4.00/0.00	5.00/0.00	ns, Min
T <sub>SMWCCK</sub> /T <sub>SMCCKW</sub>	RDWR_B Setup/Hold	10.00/0.00	10.00/0.00	10.00/0.00	12.00/0.00	ns, Min
T <sub>SMCKCSO</sub>	CSO_B clock to out (330 Ω pull-up resistor required)	7.00	7.00	7.00	8.00	ns, Max
T <sub>SMCO</sub>	D[31:00] clock to out in readback	8.00	8.00	8.00	10.00	ns, Max
F <sub>RBCCK</sub>	Readback frequency	100.00	100.00	100.00	70.00	MHz, Max
<b>Boundary-Scan Port Timing Specifications</b>						
T <sub>TAPTCK</sub> /T <sub>TCKTAP</sub>	TMS and TDI Setup/Hold	3.00/2.00	3.00/2.00	3.00/2.00	3.00/2.00	ns, Min
T <sub>TCKTDO</sub>	TCK falling edge to TDO output	7.00	7.00	7.00	8.50	ns, Max
F <sub>TCK</sub>	TCK frequency	66.00	66.00	66.00	50.00	MHz, Max
<b>BPI Master Flash Mode Programming Switching</b>						
T <sub>BPICCO</sub> <sup>(2)</sup>	A[28:00], RS[1:0], FCS_B, FOE_B, FWE_B, ADV_B clock to out	8.50	8.50	8.50	10.00	ns, Max
T <sub>BPIDCC</sub> /T <sub>BPICCD</sub>	D[15:00] Setup/Hold	4.00/0.00	4.00/0.00	4.00/0.00	4.50/0.00	ns, Min
<b>SPI Master Flash Mode Programming Switching</b>						
T <sub>SPIIDCC</sub> /T <sub>SPIICCD</sub>	D[03:00] Setup/Hold	3.00/0.00	3.00/0.00	3.00/0.00	3.00/0.00	ns, Min
T <sub>SPIICCM</sub>	MOSI clock to out	8.00	8.00	8.00	9.00	ns, Max
T <sub>SPIICCFC</sub>	FCS_B clock to out	8.00	8.00	8.00	9.00	ns, Max

**Notes:**

1. To support longer delays in configuration, use the design solutions described in [UG470: 7 Series FPGA Configuration User Guide](#).
2. Only during configuration, the last edge is determined by a weak pull-up/pull-down resistor in the I/O.

## eFUSE Programming Conditions

Table 69 lists the programming conditions specifically for eFUSE. For more information, see [UG470: 7 Series FPGA Configuration User Guide](#).

Table 69: eFUSE Programming Conditions<sup>(1)</sup>

Symbol	Description	Min	Typ	Max	Units
I <sub>FS</sub>	V <sub>CCAUX</sub> supply current	–	–	115	mA
t <sub>j</sub>	Temperature range	15	–	125	°C

**Notes:**

1. The FPGA must not be configured during eFUSE programming.

## Revision History

The following table shows the revision history for this document:

Date	Version	Description
03/01/11	1.0	Initial Xilinx release.
04/01/11	1.1	Added the XC7K355T, XC7K420T, and XC7K480T devices throughout data sheet. Added the extended temperature range discussion to <a href="#">page 1</a> . Updated $V_{CCAUX\_IO}$ in <a href="#">Table 2</a> . Edits to clarify <a href="#">Power-On/Off Power Supply Sequencing</a> power sequencing discussion. Added $I_{CCAUX\_IO}$ and $I_{CCBRAM}$ to <a href="#">Table 6</a> and <a href="#">Table 7</a> . Updated MMCM_ $F_{INDUTY}$ and added $F_{INJITTER}$ , $T_{OUTJITTER}$ , $T_{EXTFDVAR}$ , and <a href="#">Note 3</a> to <a href="#">Table 38</a> . Removed the SBG324 package from <a href="#">Table 50</a> . Updated the <a href="#">Notice of Disclaimer</a> .
10/04/11	1.2	Replaced -1L with -2L throughout this data sheet. Updated Min/Max values and removed Note 5 from <a href="#">Table 2</a> . Clarified <a href="#">Power-On/Off Power Supply Sequencing</a> power sequencing discussion including adding $T_{VCO2VCCAUX}$ to <a href="#">Table 8</a> . Updated $V_{ICM}$ in <a href="#">Table 12</a> and <a href="#">Table 13</a> . Added Note 1 to table 12. Updated <a href="#">Table 69</a> including adding <a href="#">Note 1</a> . Added <i>Absolute Maximum Ratings for GTX Transceivers</i> . Revised the reference clock maximum frequency ( $F_{GCLK}$ ) in <a href="#">Table 55</a> . Added <a href="#">Table 57</a> . Added LVTTL and removed SSTL135_II and SSTL15_II specifications from <a href="#">Table 19</a> . Removed HSTL_III from <a href="#">Table 20</a> . Removed the <i>I/O Standard Adjustment Measurement Methodology</i> section. Use IBIS for more accurate information and measurements. Updated $T_{IDELAYPAT\_JIT}$ in <a href="#">Table 26</a> . Added $T_{AS}/T_{AH}$ to <a href="#">Table 28</a> . Added $T_{RDCK\_DI\_WF\_NC}/T_{RCKD\_DI\_WF\_NC}$ and $T_{RDCK\_DI\_RF}/T_{RCKD\_DI\_RF}$ to <a href="#">Table 31</a> . Completely updated <a href="#">Table 68</a> . Updated the <a href="#">AC Switching Characteristics</a> in <a href="#">Table 19</a> , <a href="#">Table 20</a> , <a href="#">Table 21</a> , <a href="#">Table 22</a> , <a href="#">Table 23</a> , <a href="#">Table 24</a> , <a href="#">Table 26</a> through <a href="#">Table 38</a> , <a href="#">Table 40</a> though <a href="#">Table 37</a> , and <a href="#">Table 67</a> .
11/03/11	1.3	Revised the $V_{OCM}$ specification in <a href="#">Table 12</a> . Updated the <a href="#">AC Switching Characteristics</a> based upon the ISE 13.3 v1.02 speed specification throughout document including <a href="#">Table 19</a> and <a href="#">Table 20</a> . Added MMCM_ $T_{FBDELAY}$ while adding MMCM_ to the symbol names of a few specifications in <a href="#">Table 38</a> and PLL to the symbol names in <a href="#">Table 39</a> . In <a href="#">Table 40</a> through <a href="#">Table 47</a> , updated the pin-to-pin descriptions with the SSTL15 standard. Updated units in <a href="#">Table 49</a> .
02/13/12	1.4	Updated summary description on <a href="#">page 1</a> . In <a href="#">Table 2</a> , revised $V_{CCO}$ for the 3.3V HR I/O banks and updated $T_j$ . Added typical values to <a href="#">Table 3</a> . Updated the notes in <a href="#">Table 6</a> . Added MGTAVCC, MGTAVTT, and MGTVCCAUX power supply ramp times to <a href="#">Table 8</a> . Rearranged <a href="#">Table 9</a> , added Mobile_DDR, HSTL_I_18, HSTL_II_18, HSUL_12, SSTL135_R, SSTL15_R, and SSTL12 and removed DIFF_SSTL135, DIFF_SSTL18_I, DIFF_SSTL18_II, DIFF_HSTL_I, and DIFF_HSTL_II. Added <a href="#">Table 10</a> and <a href="#">Table 11</a> . Revised the specifications in <a href="#">Table 12</a> and <a href="#">Table 13</a> . Updated the <a href="#">eFUSE Programming Conditions</a> section and removed the endurance table. Added the <a href="#">IO_FIFO</a> <a href="#">Switching Characteristics</a> table. Revised $I_{CCADC}$ and updated <a href="#">Note 1</a> in <a href="#">Table 67</a> . Revised DDR LVDS transmitter data width in <a href="#">Table 16</a> . Updated the <a href="#">AC Switching Characteristics</a> based upon the ISE 13.4 v1.03 speed specification throughout document. Removed notes from <a href="#">Table 28</a> as they are no longer applicable. Updated specifications in <a href="#">Table 68</a> . Updated <a href="#">Note 1</a> in <a href="#">Table 37</a> . In the <a href="#">GTX Transceiver DC Input and Output Levels</a> section: Revised $V_{IN}$ , and added $I_{DCIN}$ and $I_{DCOUT}$ to <a href="#">Table 51</a> . Added <a href="#">Note 4</a> to <a href="#">Table 53</a> . In <a href="#">Table 55</a> , revised $F_{GCLK}$ , removed $T_{PHASE}$ , and added $T_{DLOCK}$ . Revised specifications and added <a href="#">Note 2</a> to <a href="#">Table 57</a> . Added <a href="#">Table 58</a> and <a href="#">Table 59</a> along with <a href="#">GTX Transceiver Protocol Jitter Characteristics</a> in <a href="#">Table 60</a> through <a href="#">Table 65</a> .
05/23/12	1.5	Reorganized entire data sheet including adding <a href="#">Table 44</a> and <a href="#">Table 48</a> . Updated $T_{SOL}$ in <a href="#">Table 1</a> . Updated $I_{BATT}$ and added $R_{IN\_TERM}$ to <a href="#">Table 3</a> . Added values to <a href="#">Table 6</a> and <a href="#">Table 7</a> . Updated <a href="#">Power-On/Off Power Supply Sequencing</a> , <a href="#">page 6</a> with regards to GTX transceivers. Updated many parameters in <a href="#">Table 9</a> including SSTL135 and SSTL135_R. Removed $V_{OX}$ column and added DIFF_HSUL_12 to <a href="#">Table 11</a> . Updated $V_{OL}$ in <a href="#">Table 12</a> . Updated <a href="#">Table 16</a> and removed notes 2 and 3. Updated <a href="#">Table 17</a> . Updated the <a href="#">AC Switching Characteristics</a> based upon the ISE 14.1 v1.04 for the -3, -2, -2L (1.0V), -1, and -2L (0.9V) speed specifications throughout the document. In <a href="#">Table 31</a> , updated <a href="#">Reset Delays</a> section including <a href="#">Note 10</a> and <a href="#">Note 11</a> . Added data for $T_{LOCK}$ and $T_{DLOCK}$ in <a href="#">Table 55</a> . Updated many of the XADC specifications in <a href="#">Table 67</a> and added <a href="#">Note 2</a> . Updated and moved <i>Dynamic Reconfiguration Port (DRP) for MMCM Before and After DCLK</i> section from <a href="#">Table 68</a> to <a href="#">Table 38</a> and <a href="#">Table 39</a> .

Date	Version	Description
07/25/12	1.6	<p>Updated the descriptions, changed <math>V_{IN}</math> and <a href="#">Note 2</a> and added <a href="#">Note 4</a> in <a href="#">Table 1</a>. In <a href="#">Table 2</a>, changed descriptions and notes, removed Note 7, changed GTX transceiver parameters and values and added <a href="#">Note 9</a>. Updated parameters in <a href="#">Table 3</a>. Added <a href="#">Table 4</a> and <a href="#">Table 5</a>.</p> <p>Changed the typical values for many of the devices in <a href="#">Table 7</a>. Updated LVCMOS12 and the SSTLs in <a href="#">Table 9</a>. Updated many of the specifications in <a href="#">Table 10</a> and <a href="#">Table 11</a>.</p> <p>Updated speed specification to v1.06 (-3, -2, -2L(1.0V), -1) and v1.05 (-2L(0.9V)) with appropriate changes to <a href="#">Table 14</a> and <a href="#">Table 15</a> including production release of the XC7K325T and the XC7K410T in the -2, -2L(1.0V), and -1 speed designations.</p> <p>Added notes and specifications to <a href="#">Table 17</a> and <a href="#">Table 18</a>.</p> <p>Updated the <a href="#">IOB Pad Input/Output/3-State</a> discussion and changed <a href="#">Table 21</a> by adding <math>T_{IOIBUFDISABLE}</math>.</p> <p>Removed many of the combinatorial delay specifications and <math>T_{CINCK}/T_{CKCIN}</math> from <a href="#">Table 28</a>.</p> <p>Rearranged <a href="#">Table 51</a> including moving some parameters to <a href="#">Table 1</a>. Added <a href="#">Table 56</a>. Updated <a href="#">Table 57</a>. In <a href="#">Table 59</a>, updated SJ Jitter Tolerance with Stressed Eye section, <a href="#">page 51</a> and <a href="#">Note 8</a>.</p> <p>Added <a href="#">Note 1</a>, <a href="#">Note 2</a>, and <a href="#">Note 3</a> to <a href="#">Table 62</a>. Added <a href="#">Note 1</a> and <a href="#">Note 2</a> to <a href="#">Table 63</a>, and line rate ranges. Updated <a href="#">Table 64</a> including adding <a href="#">Note 1</a>. Updated <a href="#">Table 65</a> including adding <a href="#">Note 1</a>.</p> <p>In <a href="#">Table 67</a> updated <a href="#">Note 1</a> and added Note 4. In <a href="#">Table 68</a>, updated <math>T_{POR}</math> and <math>F_{EMCCK}</math>.</p>
09/04/12	1.7	Updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of the XC7K160T in the -2, -2L(1.0V), and -1 speed designations.
09/26/12	1.8	In <a href="#">Table 2</a> , revised $V_{CCINT}$ and $V_{CCBRAM}$ and added <a href="#">Note 2</a> . Updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of the XC7K480T in the -2, -2L(1.0V), and -1 speed designations and the XC7K325T and XC7K410T in the -3 speed designation.
10/10/12	1.9	Updated the $I_{CCINTMIN}$ value for the XC7K355T in <a href="#">Table 7</a> . Updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of the XC7K420T in the -2, -2L(1.0V), and -1 speed designations.
10/25/12	2.0	<p>Updated the <a href="#">AC Switching Characteristics</a> based upon ISE 14.3 v1.07 for the -3, -2, -2L (1.0V), -1 speed specifications, and ISE 14.3 v1.06 for the -2L (0.9V) speed specifications throughout the document.</p> <p>Updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of the XC7K355T in the -2, -2L(1.0V), and -1 speed designations. Also updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of the XC7K325T and XC7K410T in the -2L (0.9V).</p> <p>Added values for <a href="#">Table 16</a> -2L (0.9V). Added package skew values to <a href="#">Table 50</a>. In <a href="#">Table 53</a>, increased -1 speed grade (FF package) <math>F_{GTXMAX}</math> value from 6.6 Gb/s to 8.0 Gb/s.</p>
10/31/12	2.1	Updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of the XC7K70T in the -2, -2L(1.0V), and -1 speed designations.
11/26/12	2.2	Updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of -3 speed designation for XC7K70T, XC7K160T, XC7K355T, XC7K420T, and XC7K480T. Removed Note 4 from <a href="#">Table 67</a> .
12/05/12	2.3	Updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of the -2L (0.9V) speed designation for XC7K160T, XC7K420T, and XC7K480T. Updated <a href="#">Note 1</a> in <a href="#">Table 50</a> .
12/12/12	2.4	Updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of the -2L (0.9V) speed designation for XC7K70T and XC7K355T. Added <a href="#">Internal Configuration Access Port</a> section to <a href="#">Table 68</a> .